## NID9N05ACL, NID9N05BCL

## Power MOSFET

### 9.0 A, 52 V, N-Channel, Logic Level, Clamped MOSFET w/ESD Protection in a DPAK Package

## Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation


## Features

- Diode Clamp Between Gate and Source
- ESD Protection - HBM 5000 V
- Active Over-Voltage Gate to Drain Clamp
- Scalable to Lower or Higher $\mathrm{R}_{\mathrm{DS}(o n)}$
- Internal Series Gate Resistance
- AEC-Q101 Qualified and PPAP Capable
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free/BFR Free and are RoHS Compliant


## Applications

- Automotive and Industrial Markets:

Solenoid Drivers, Lamp Drivers, Small Motor Drivers

MAXIMUM RATINGS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Rating | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: |
| Drain-to-Source Voltage Internally Clamped | $\mathrm{V}_{\text {DSS }}$ | 52-59 | V |
| Gate-to-Source Voltage - Continuous | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 15$ | V |
| Drain Current - Continuous @ $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ <br> - Single Pulse ( $\mathrm{t}_{\mathrm{p}}=10 \mu \mathrm{~s}$ ) | $\begin{aligned} & \mathrm{I}_{\mathrm{D}} \\ & \mathrm{I}_{\mathrm{DM}} \end{aligned}$ | $\begin{aligned} & 9.0 \\ & 35 \end{aligned}$ | A |
| Total Power Dissipation @ $\mathrm{A}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 1.74 | W |
| Operating and Storage Temperature Range | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | -55 to 175 | ${ }^{\circ} \mathrm{C}$ |
| $\begin{aligned} & \text { Single Pulse Drain-to-Source Avalanche } \\ & \text { Energy - Starting } \mathrm{T}_{J}=125^{\circ} \mathrm{C} \\ & \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}(\mathrm{pk})}=1.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \\ & \left.\mathrm{R}_{\mathrm{G}}=25 \Omega\right) \end{aligned}$ | $\mathrm{E}_{\text {AS }}$ | 160 | mJ |
| Thermal Resistance, Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2) | $\begin{aligned} & \mathrm{R}_{\theta \mathrm{AJC}} \\ & \mathrm{R}_{\theta \mathrm{AJA}} \\ & \mathrm{R}_{\theta \mathrm{AJ}} \\ & \hline \end{aligned}$ | $\begin{gathered} 5.2 \\ 72 \\ 100 \end{gathered}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Maximum Lead Temperature for Soldering Purposes, $1 / 8^{\prime \prime}$ from Case for 10 seconds | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in $^{2}$ ).
2. When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in$^{2}$ ).


## ON Semiconductor ${ }^{\circledR}$

www.onsemi.com


ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :---: | :---: | :---: |
| NID9N05ACLT4G | DPAK <br> (Pb-Free) | 2500/Tape \& Reel |
| NID9N05BCLT4G | DPAK <br> (Pb-Free) | 2500/Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| OFF CHARACTERISTICS |  |  |  |  |  |
| Drain-to-Source Breakdown Voltage (Note 3) $\begin{aligned} & \left(\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.0 \mathrm{~mA}, \mathrm{~T}_{J}=25^{\circ} \mathrm{C}\right) \\ & \left.\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.0 \mathrm{~mA}, \mathrm{~T}_{J}=-40^{\circ} \mathrm{C} \text { to } 125^{\circ} \mathrm{C}\right) \end{aligned}$ <br> Temperature Coefficient (Negative) | $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$ | $\begin{gathered} 52 \\ 50.8 \end{gathered}$ | $\begin{gathered} 55 \\ 54 \\ -10 \end{gathered}$ | $\begin{gathered} 59 \\ 59.5 \end{gathered}$ |  |
| Zero Gate Voltage Drain Current $\begin{aligned} & \left(\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}\right) \\ & \left(\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}\right) \end{aligned}$ | IDSS | - | - | $\begin{aligned} & 10 \\ & 25 \end{aligned}$ | $\mu \mathrm{A}$ |
| Gate-Body Leakage Current $\begin{aligned} & \left(\mathrm{V}_{\mathrm{GS}}= \pm 8 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}= \pm 14 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}\right) \end{aligned}$ | $I_{\text {GSS }}$ | - | $\pm \overline{2}$ | $\pm 10$ | $\mu \mathrm{A}$ |

ON CHARACTERISTICS (Note 3)

| Gate Threshold Voltage (Note 3) $\begin{aligned} & \quad\left(\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=100 \mu \mathrm{~A}\right) \\ & \text { Threshold Temperature Coefficient (Negative) } \end{aligned}$ | $\mathrm{V}_{\mathrm{GS} \text { (th) }}$ | $1.3$ | $\begin{array}{r} 1.75 \\ -4.5 \end{array}$ | 2.5 | $\begin{gathered} \mathrm{V} \\ \mathrm{mV} /{ }^{\circ} \mathrm{C} \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Static Drain-to-Source On-Resistance (Note 3) $\begin{aligned} & \left(\mathrm{V}_{\mathrm{GS}}=4.0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1.5 \mathrm{~A}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}=3.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=0.6 \mathrm{~A}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}=3.0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=0.2 \mathrm{~A}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}=12 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=9.0 \mathrm{~A}\right) \\ & \left(\mathrm{V}_{\mathrm{GS}}=12 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=12 \mathrm{~A}\right) \end{aligned}$ | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\begin{aligned} & \overline{7} \\ & 70 \end{aligned}$ | $\begin{gathered} 153 \\ 175 \\ - \\ 90 \\ 95 \end{gathered}$ | $\begin{gathered} 181 \\ 364 \\ 1210 \end{gathered}$ | $\mathrm{m} \Omega$ |
| Forward Transconductance (Note 3) ( $\left.\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=9.0 \mathrm{~A}\right)$ | gFS | - | 24 | - | Mhos |

DYNAMIC CHARACTERISTICS

| Input Capacitance | $\left(\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=10 \mathrm{kHz}\right)$ | $\mathrm{C}_{\text {iss }}$ | - | 155 | 250 | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Output Capacitance |  | $\mathrm{C}_{\text {oss }}$ | - | 60 | 100 |  |
| Transfer Capacitance |  | $\mathrm{C}_{\text {rss }}$ | - | 25 | 40 |  |
| Input Capacitance | $\left(\mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=10 \mathrm{kHz}\right)$ | $\mathrm{C}_{\text {iss }}$ | - | 175 | - | pF |
| Output Capacitance |  | Coss | - | 70 | - |  |
| Transfer Capacitance |  | $\mathrm{C}_{\text {rss }}$ | - | 30 | - |  |

SWITCHING CHARACTERISTICS (Note 4)

| Turn-On Delay Time | $\begin{gathered} \left(\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=40 \mathrm{~V},\right. \\ \left.\mathrm{I}_{\mathrm{D}}=9.0 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=9.0 \Omega\right) \end{gathered}$ | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | - | 130 | 200 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Rise Time |  | $t_{r}$ | - | 500 | 750 |  |
| Turn-Off Delay Time |  | $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | - | 1300 | 2000 |  |
| Fall Time |  | $\mathrm{t}_{\mathrm{f}}$ | - | 1150 | 1850 |  |
| Turn-On Delay Time | $\begin{gathered} \left(\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=15 \mathrm{~V},\right. \\ \left.\mathrm{I}_{\mathrm{D}}=1.5 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=2 \mathrm{k} \Omega\right) \end{gathered}$ | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | - | 200 | - | ns |
| Rise Time |  | $t_{r}$ | - | 500 | - |  |
| Turn-Off Delay Time |  | $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | - | 2500 | - |  |
| Fall Time |  | $\mathrm{t}_{\mathrm{f}}$ | - | 1800 | - |  |
| Turn-On Delay Time | $\begin{gathered} \left(\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=15 \mathrm{~V}\right. \\ \left.\mathrm{I}_{\mathrm{D}}=1.5 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=50 \Omega\right) \end{gathered}$ | $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | - | 120 | - | ns |
| Rise Time |  | $\mathrm{tr}_{\mathrm{r}}$ | - | 275 | - |  |
| Turn-Off Delay Time |  | $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | - | 1600 | - |  |
| Fall Time |  | $\mathrm{t}_{\mathrm{f}}$ | - | 1100 | - |  |
| Gate Charge | $\begin{gathered} \left(\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=40 \mathrm{~V},\right. \\ \left.\mathrm{I}_{\mathrm{D}}=9.0 \mathrm{~A}\right)(\text { Note 3) } \end{gathered}$ | $Q_{\text {T }}$ | - | 4.5 | 7.0 | nC |
|  |  | $Q_{1}$ | - | 1.2 | - |  |
|  |  | $Q_{2}$ | - | 2.7 | - |  |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Pulse Test: Pulse Width $\leq 300 \mu \mathrm{~s}$, Duty Cycle $\leq 2 \%$.
4. Switching characteristics are independent of operating junction temperatures.

## NID9N05ACL, NID9N05BCL

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Characteristic |  | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SWITCHING CHARACTERISTICS (Note 4) |  |  |  |  |  |  |
| Gate Charge | $\begin{gathered} \left(\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=15 \mathrm{~V},\right. \\ \left.\mathrm{I}_{\mathrm{D}}=1.5 \mathrm{~A}\right)(\text { Note 3) } \end{gathered}$ | $\mathrm{Q}_{\mathrm{T}}$ | - | 3.6 | - | $n \mathrm{C}$ |
|  |  | $Q_{1}$ | - | 1.0 | - |  |
|  |  | $\mathrm{Q}_{2}$ | - | 2.0 | - |  |

SOURCE-DRAIN DIODE CHARACTERISTICS

| Forward On-Voltage | $\begin{gathered} \left(\mathrm{I}_{\mathrm{S}}=4.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}\right)(\text { Note } 3) \\ \left(\mathrm{IS}_{\mathrm{S}}=4.0 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}\right) \\ \left(\mathrm{I}_{\mathrm{S}}=4.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}\right) \end{gathered}$ | $\mathrm{V}_{\text {SD }}$ | - | $\begin{gathered} \hline 0.86 \\ 0.845 \\ 0.725 \end{gathered}$ | 1.2 - - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reverse Recovery Time | $\left(\mathrm{I}_{\mathrm{S}}=4.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V},\right.$ <br> $\left.\mathrm{dl}_{\mathrm{s}} / \mathrm{dt}=100 \mathrm{~A} / \mathrm{\mu s}\right)($ Note 3$)$ | $\mathrm{t}_{\mathrm{rr}}$ | - | 700 | - | ns |
|  |  | $\mathrm{t}_{\mathrm{a}}$ | - | 200 | - |  |
|  |  | $t_{b}$ | - | 500 | - |  |
| Reverse Recovery Stored Charge |  | $\mathrm{Q}_{\mathrm{RR}}$ | - | 6.5 | - | $\mu \mathrm{C}$ |

## ESD CHARACTERISTICS

| Electro-Static Discharge Capability | Human Body Model (HBM) | ESD | 5000 | - | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Machine Model (MM) |  | 500 | - | - |  |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Pulse Test: Pulse Width $\leq 300 \mu \mathrm{~s}$, Duty Cycle $\leq 2 \%$.
4. Switching characteristics are independent of operating junction temperatures.

## NID9N05ACL, NID9N05BCL

TYPICAL PERFORMANCE CURVES


Figure 1. On-Region Characteristics


Figure 3. On-Resistance versus
Gate-to-Source Voltage


Figure 5. On-Resistance Variation with Temperature


Figure 2. Transfer Characteristics


Figure 4. On-Resistance versus Drain Current and Gate Voltage


Figure 6. Drain-to-Source Leakage Current versus Voltage

## NID9N05ACL, NID9N05BCL

TYPICAL PERFORMANCE CURVES


Figure 7. Capacitance Variation


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge


Figure 9. Resistive Switching Time Variation versus Gate Resistance

DRAIN-TO-SOURCE DIODE CHARACTERISTICS


Figure 10. Diode Forward Voltage versus Current

## NID9N05ACL, NID9N05BCL

## SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature $\left(\mathrm{T}_{\mathrm{C}}\right)$ of $25^{\circ} \mathrm{C}$. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current ( $\mathrm{I}_{\mathrm{DM}}$ ) nor rated voltage ( $\mathrm{V}_{\mathrm{DSS}}$ ) is exceeded and the transition time $\left(\mathrm{t}_{\mathrm{r}}, \mathrm{t}_{\mathrm{f}}\right)$ do not exceed $10 \mu \mathrm{~s}$. In addition the total power averaged over a complete switching cycle must not exceed $\left(T_{J(M A X)}-T_{C}\right) /\left(R_{\theta J C}\right)$.

A Power MOSFET designated E-FET can be safely used in switching circuits with unclamped inductive loads. For
reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non-linearly with an increase of peak current in avalanche and peak junction temperature.
Although many E-FETs can withstand the stress of drain-to-source avalanche at currents up to rated pulsed current ( $\mathrm{I}_{\mathrm{DM}}$ ), the energy rating is specified at rated continuous current ( $\mathrm{I}_{\mathrm{D}}$ ), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 12). Maximum energy at currents below rated continuous $\mathrm{I}_{\mathrm{D}}$ can safely be assumed to equal the values indicated.


Figure 11. Maximum Rated Forward Biased Safe Operating Area


Figure 12. Thermal Response


## DPAK (SINGLE GAUGE)

CASE 369C
ISSUE F
DATE 21 JUL 2015
SCALE 1:1


| STYLE 1: | STYLE 2: | STYLE 3: | STYLE 4: | STYLE 5: |
| :---: | :---: | :---: | :---: | :---: |
| PIN 1. BASE | PIN 1. GATE | PIN 1. ANODE | PIN 1. CATHODE | PIN 1. GATE |
| 2. COLLECTOR | 2. DRAIN | 2. CATHODE | 2. ANODE | 2. ANODE |
| 3. EMITTER | 3. SOURCE | 3. ANODE | 3. GATE | 3. CATHODE |
| 4. COLLECTOR | 4. DRAIN | 4. CATHODE | 4. ANODE | 4. ANODE |


| STYLE 6: | STYLE 7: | STYLE 8: | STYLE 9: | STYLE 10: |
| :---: | :---: | :---: | :---: | :---: |
| PIN 1. MT1 | PIN 1. GATE | PIN 1. N/C | PIN 1. ANODE | PIN 1. CATHODE |
| 2. MT2 | 2. COLLECTOR | 2. CATHODE | 2. CATHODE | 2. ANODE |
| 3. GATE | 3. EMITTER | 3. ANODE | 3. RESISTOR ADJUST | 3. CATHODE |
| 4. MT2 | 4. COLLECTOR | 4. CATHODE | 4. CATHODE | 4. ANODE |

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: INCHES
3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-

MENSIONS b3, L3 and Z.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
7. OPTIONAL MOLD FEATURE.

|  | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |
| A | 0.086 | 0.094 | 2.18 | 2.38 |
| A1 | 0.000 | 0.005 | 0.00 | 0.13 |
| b | 0.025 | 0.035 | 0.63 | 0.89 |
| b2 | 0.028 | 0.045 | 0.72 | 1.14 |
| b3 | 0.180 | 0.215 | 4.57 | 5.46 |
| C | 0.018 | 0.024 | 0.46 | 0.61 |
| c2 | 0.018 | 0.024 | 0.46 | 0.61 |
| D | 0.235 | 0.245 | 5.97 | 6.22 |
| E | 0.250 | 0.265 | 6.35 | 6.73 |
| e | 0.090 | BSC | 2.29 BSC |  |
| H | 0.370 | 0.410 | 9.40 |  |
| 10.41 |  |  |  |  |
| L | 0.055 | 0.070 | 1.40 | 1.78 |
| L1 | 0.114 | REF | 2.90 |  |
| REF |  |  |  |  |
| L2 | 0.020 | BSC | 0.51 BSC |  |
| L3 | 0.035 | 0.050 | 0.89 | 1.27 |
| L4 | --- | 0.040 | --- | 1.01 |
| $\mathbf{Z}$ | 0.155 | --- | 3.93 | --- |

GENERIC
MARKING DIAGRAM*


IC


Discrete


A

| A | $=$ Assembly Location |
| :--- | :--- |
| L | $=$ Wafer Lot |
| Y | $=$ Year |
| WW | $=$ Work Week |
| G | $=$ Pb-Free Package |

*This information is generic. Please refer to device data sheet for actual part marking.
*For additional information on our $\mathrm{Pb}-$ Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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| ---: | :--- | :--- | :--- |
| DESCRIPTION: | DPAK (SINGLE GAUGE) | PAGE 1 OF 1 |

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